

**Search Notes**

Application/Control No.

10/693,150

Examiner

Paul Dinh

Applicant(s)/Patent under  
Reexamination

BAUGH ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	1, 4, 8-9	12/5/2005	PD
716	12-13	12/5/2005	PD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, IEEE	12/5/2005	PD